

Search Notes 	Application/Control No.	Applicant(s)/Patent under Reexamination
	10/711,224	HYDE ET AL.
	Examiner	Art Unit
	Mohamed Charioui	2857

SEARCHED			
Class	Subclass	Date	Examiner
702	57, 60, 65, 93, 99, 116, 119	5/22/2006	MC
702	130, 136	5/22/2006	MC
702	170, 182	5/22/2006	MC
702	183, 189	5/22/2006	MC
702	193	5/22/2006	MC
257	59, 347	5/22/2006	MC
257	401, 577	5/22/2006	MC
257	706	5/22/2006	MC
438	163	5/22/2006	MC
Search	updated	8/6/2007	MC

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner